

Features

- Fast switching
- Uses advanced SGT technology
- Low gate charge and Low on-resistance
- 100% avalanche tested

Product Summary			
V _{DS}	R _{DS(on)} (mΩ) Typ	I _D (A)	Q _g (Typ)
100V	8 @ 10V 30A	70	31nc



Mechanical Data

- Case:TO-252 Package

Application

- Motor control and drives
- DC-DC converters
- Battery management
- General purpose applications

Ordering Information

Part No.	Package Type	Package	Quality(box)
DS70N10M	TO-252	Tape & Reel	2500

Block Diagram

Pin Definition:

1. Gate
2. Drain
3. Source

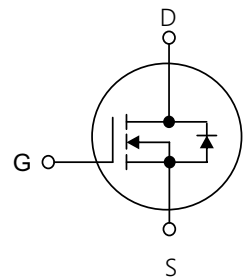


Table1 Absolute Maximum Ratings (T_c=25°C, unless otherwise specified)

Parameter	Symbol	D70N10M	Unit
Drain-Source Voltage	V _{DS}	100	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current (Note 5)	I _D	T _c =25°C	70
		T _c =100°C	48
Pulsed Drain Current (Note 1)	I _{DM}	272	A
Single Pulse Avalanche Energy(Note 2)	E _{AS}	156	mJ
Power Dissipation T _c =25°C	P _D	86	W
Operating Junction and Storage Temperature	T _J /T _{STG}	-55~+150	°C

※ limited by maximum junction temperature

Table 2. Thermal Characteristics

Parameter	Symbol	DS70N10M	Unit
Thermal resistance Junction to Ambient	$R_{\theta JA}$	75	$^{\circ}\text{C}/\text{W}$
Thermal resistance Junction to Case	$R_{\theta JC}$	1.45	$^{\circ}\text{C}/\text{W}$

 Table 3. Electrical Characteristics ($T_c=25^{\circ}\text{C}$, unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit	
Off Characteristics							
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu\text{A}$	100	-	-	V	
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=100V, V_{GS}=0V$	-	-	1	μA	
Gate- Source Leakage Current	Forward	I_{GSS}	$V_{GS}=20V, V_{DS}=0V$	-	-	100	nA
	Reverse	I_{GSS}	$V_{GS}=-20V, V_{DS}=0V$	-	-	-100	nA
On Characteristics(Note 3)							
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.3	-	2.3	V	
Static Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=30A$	-	8	9.5	m Ω	
		$V_{GS}=4.5V, I_D=30A$	-	11	13.5		
Dynamic Characteristics(Note 4)							
Input Capacitance	C_{ISS}	$V_{DS}=50V, V_{GS}=0V, f=1\text{MHz}$	-	1700	-	pF	
Output Capacitance	C_{OSS}		-	454	-	pF	
Reverse Transfer Capacitance	C_{RSS}		-	26	-	pF	
Switching Characteristics (Note 4)							
Turn-On Delay Time	$t_{d(on)}$	$V_{DD}=50V, I_D=30A$ $V_{GS}=10V, R_G=3\Omega,$	-	8	-	ns	
Turn-On Rise Time	t_r		-	23	-	ns	
Turn-Off Delay Time	$t_{d(off)}$		-	26	-	ns	
Turn-Off Fall Time	t_f		-	8	-	ns	
Total Gate Charge	Q_G	$V_{DD}=50V, I_D=30A,$ $V_{GS}=10V$	-	31	-	nC	
Gate-Source Charge	Q_{GS}		-	6	-	nC	
Gate-Drain Charge	Q_{GD}		-	7	-	nC	
Drain-Source Diode Characteristics and Maximum Ratings							
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_S=30A$	-	-	1.2	V	
Maximum Continuous Drain-Source Diode Forward Current	I_S		-	-	70	A	
Reverse Recovery Time	t_{rr}	$V_{GS}=0V, I_F=30A$	-	48	-	ns	
Reverse Recovery Charge	Q_{RR}	$dI_F/dt=100A/\mu\text{s}$ (Note 1)	-	76	-	nC	

- Notes: 1 Repetitive Rating:Pulse width limited by maximum junction temperature
 2 $L=0.5\text{mH}, R_G=25\Omega$, Starting $T_J=25^{\circ}\text{C}$
 3 Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$
 4 Guaranteed by design, not subject to production
 5 The maximum current is limited by the package.

Typical Characteristics Diagrams

Figure 1. Output Characteristics

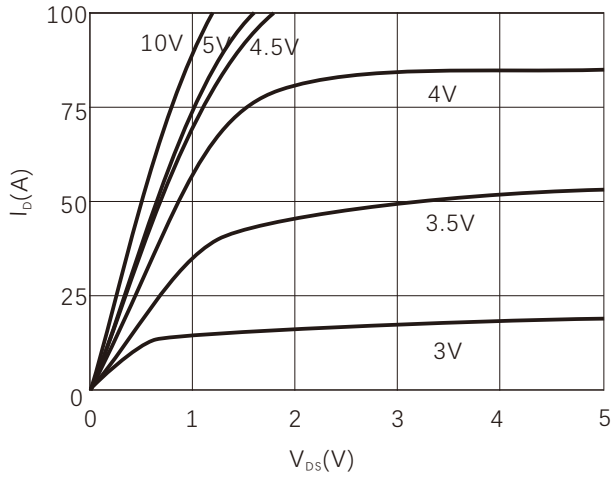


Figure 2. Transfer Characteristics

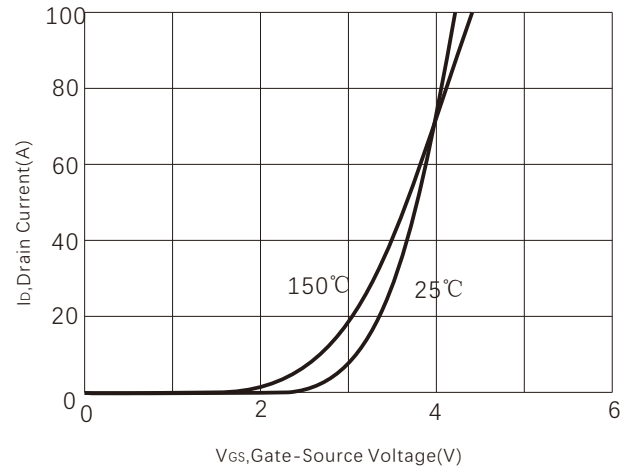


Figure 3. Normalized $R_{DS(ON)}$ vs Temperature

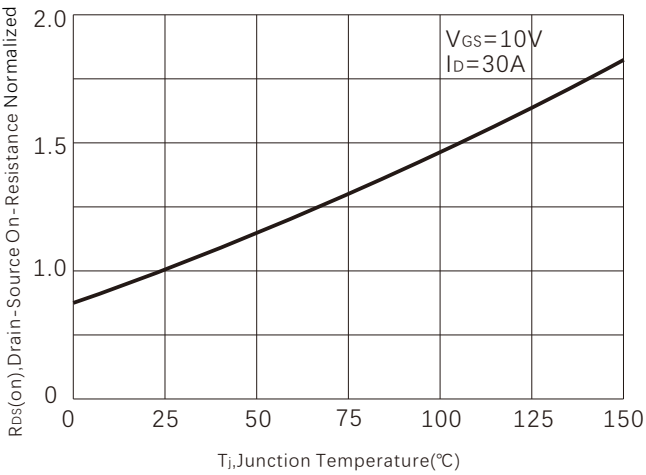


Figure 4. Capacitance

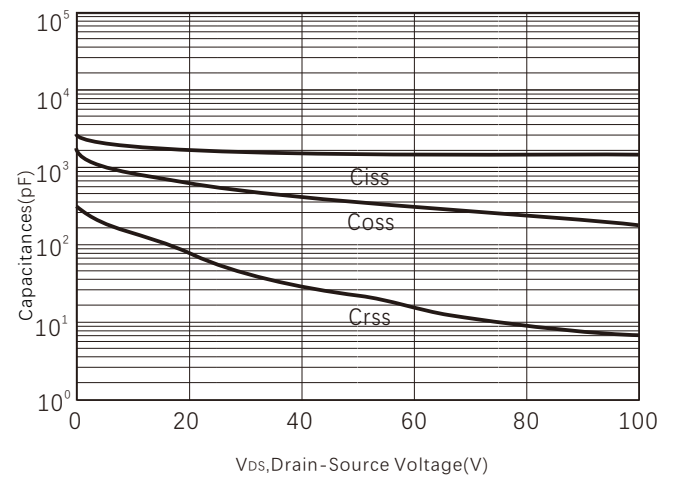


Figure 5. Gate charge

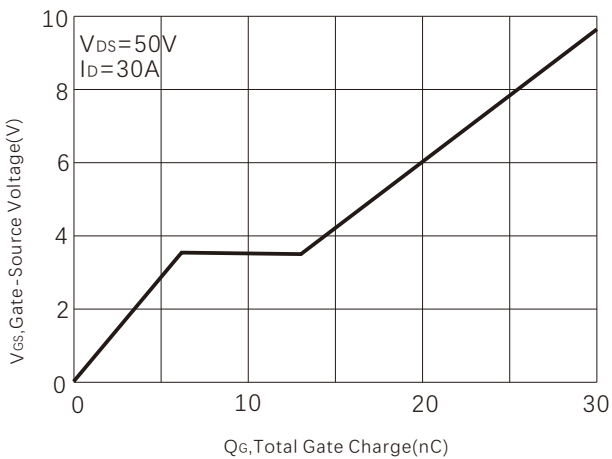


Figure 6. Source-Drain Diode Forward Voltage

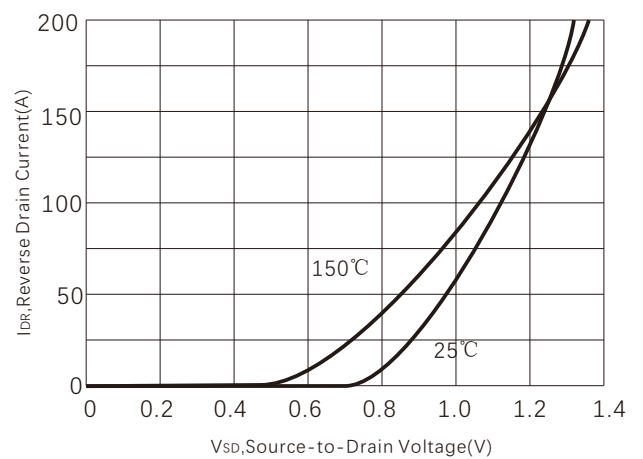


Figure 7. Maximum Drain Current vs Temperature

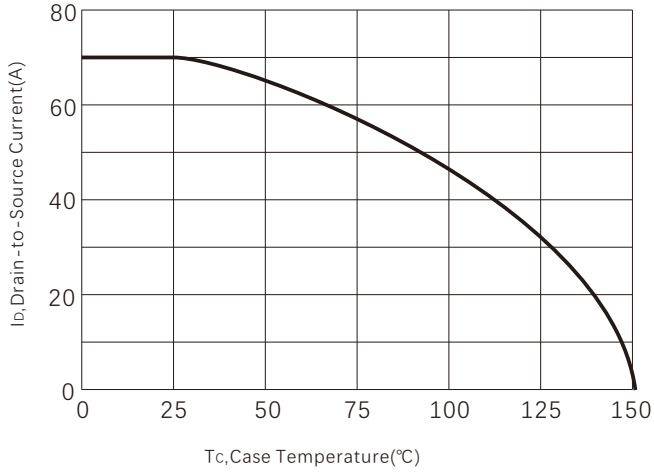


Figure 8. Power dissipation

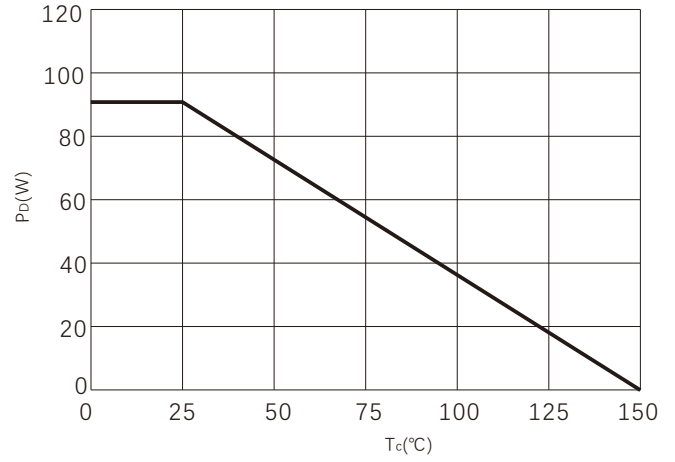


Figure 9.

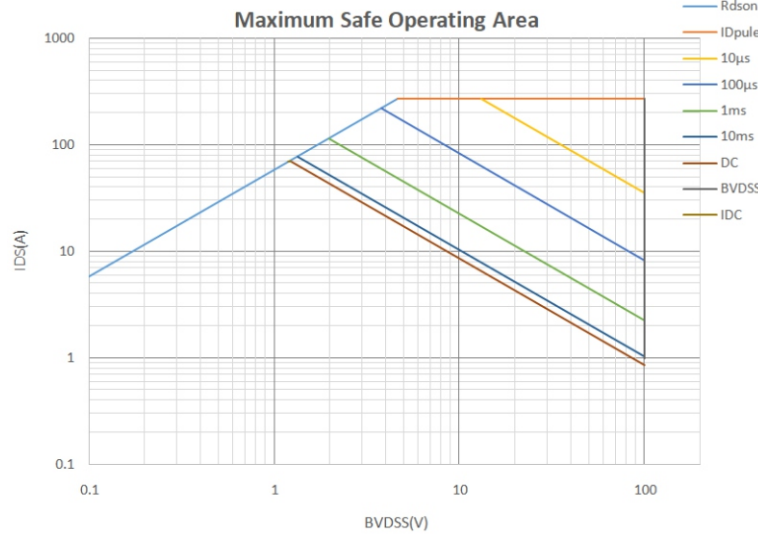
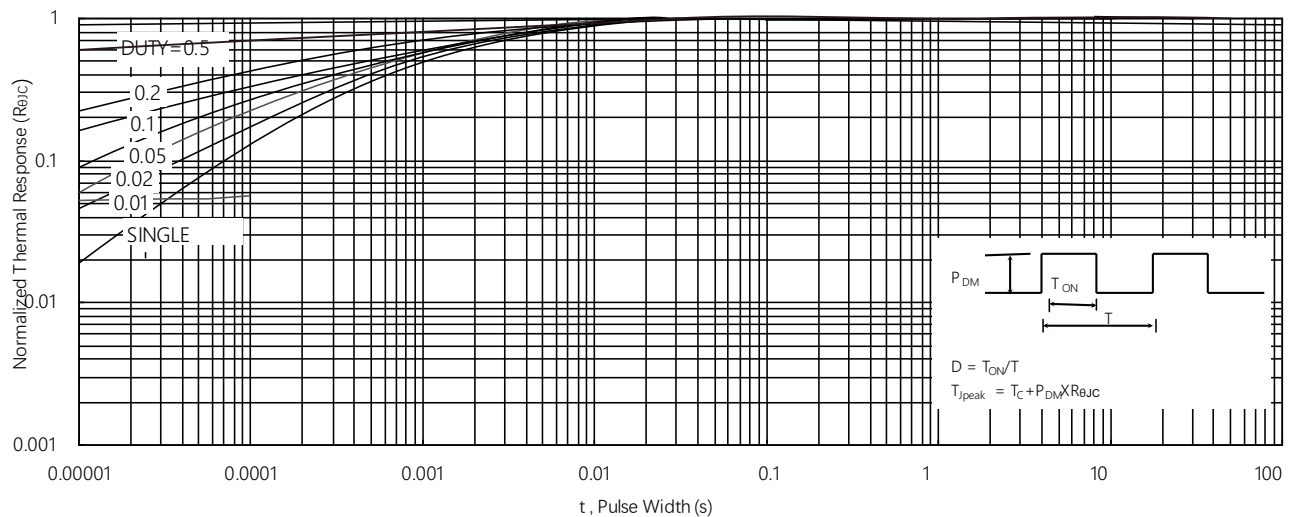
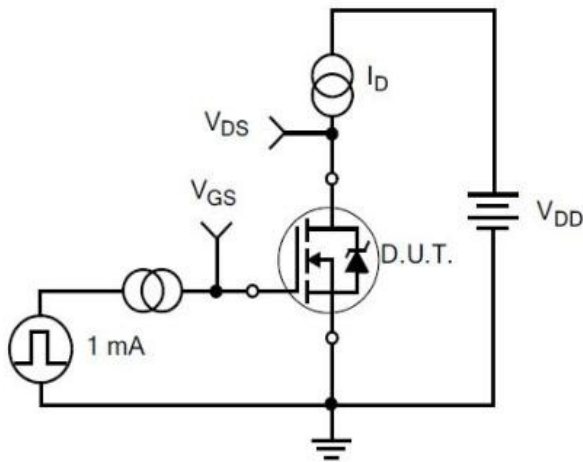


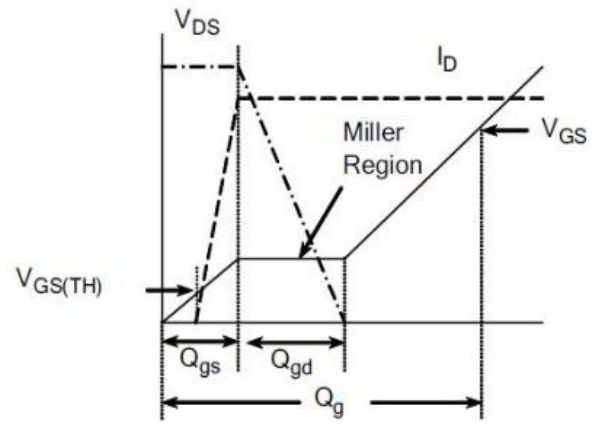
Figure 10. Normalized Maximum Transient Thermal Impedance



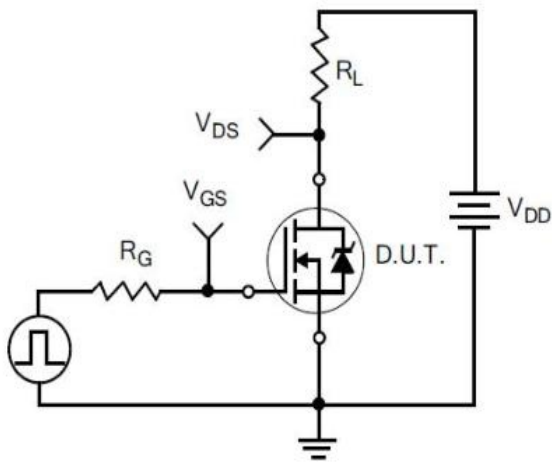
Typical Test Circuit



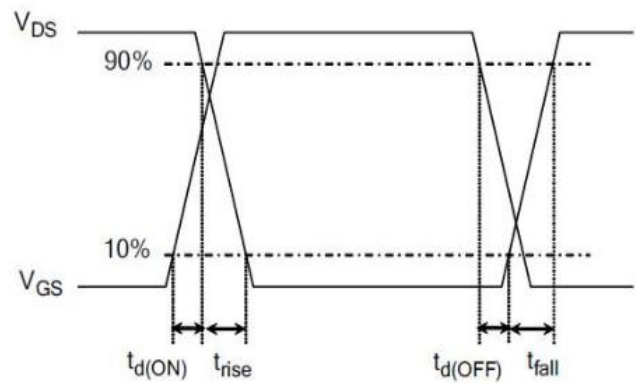
1) Gate Charge Test Circuit



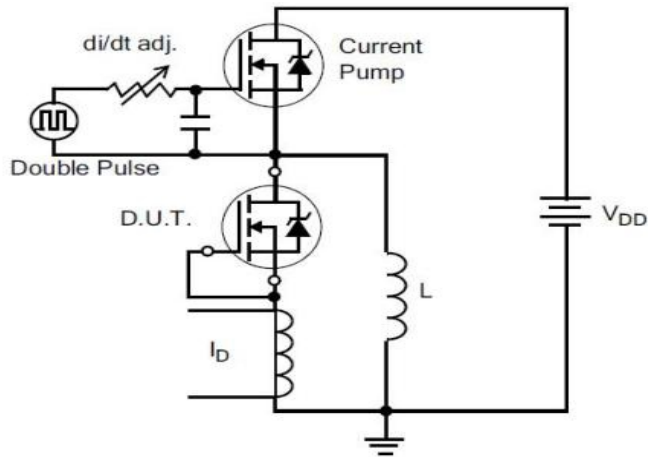
2) Gate Charge Waveform



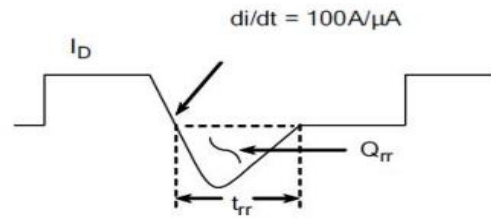
3) Resistive Switching Test Circuit



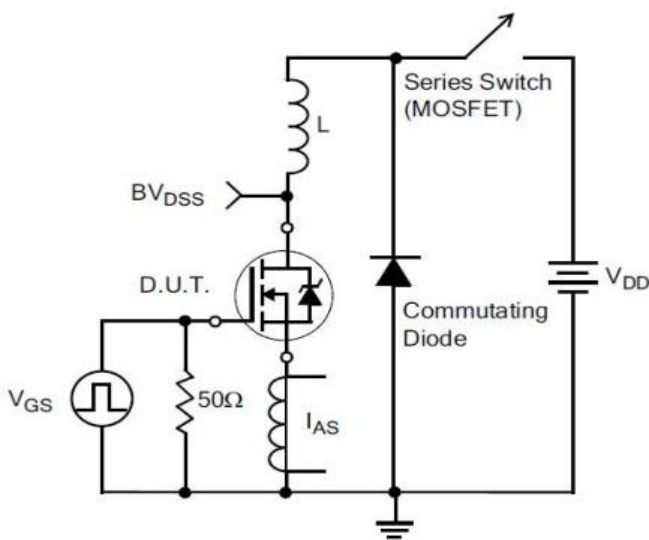
4) Resistive Switching Waveforms



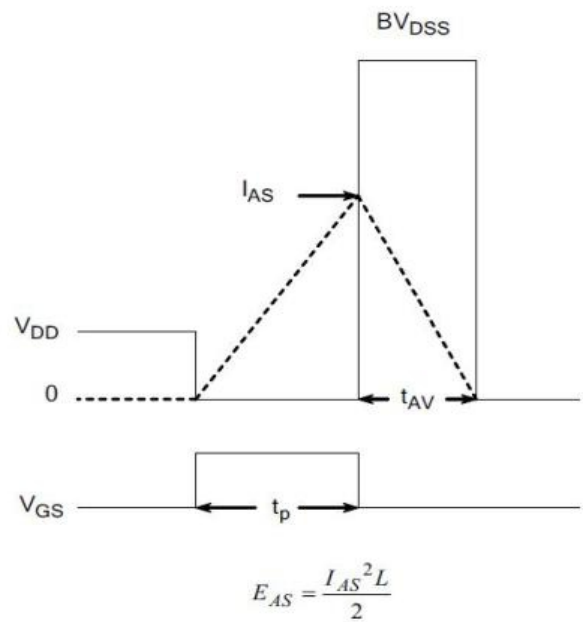
5) Diode Reverse Recovery Test Circuit



6) Diode Reverse Recovery Waveform



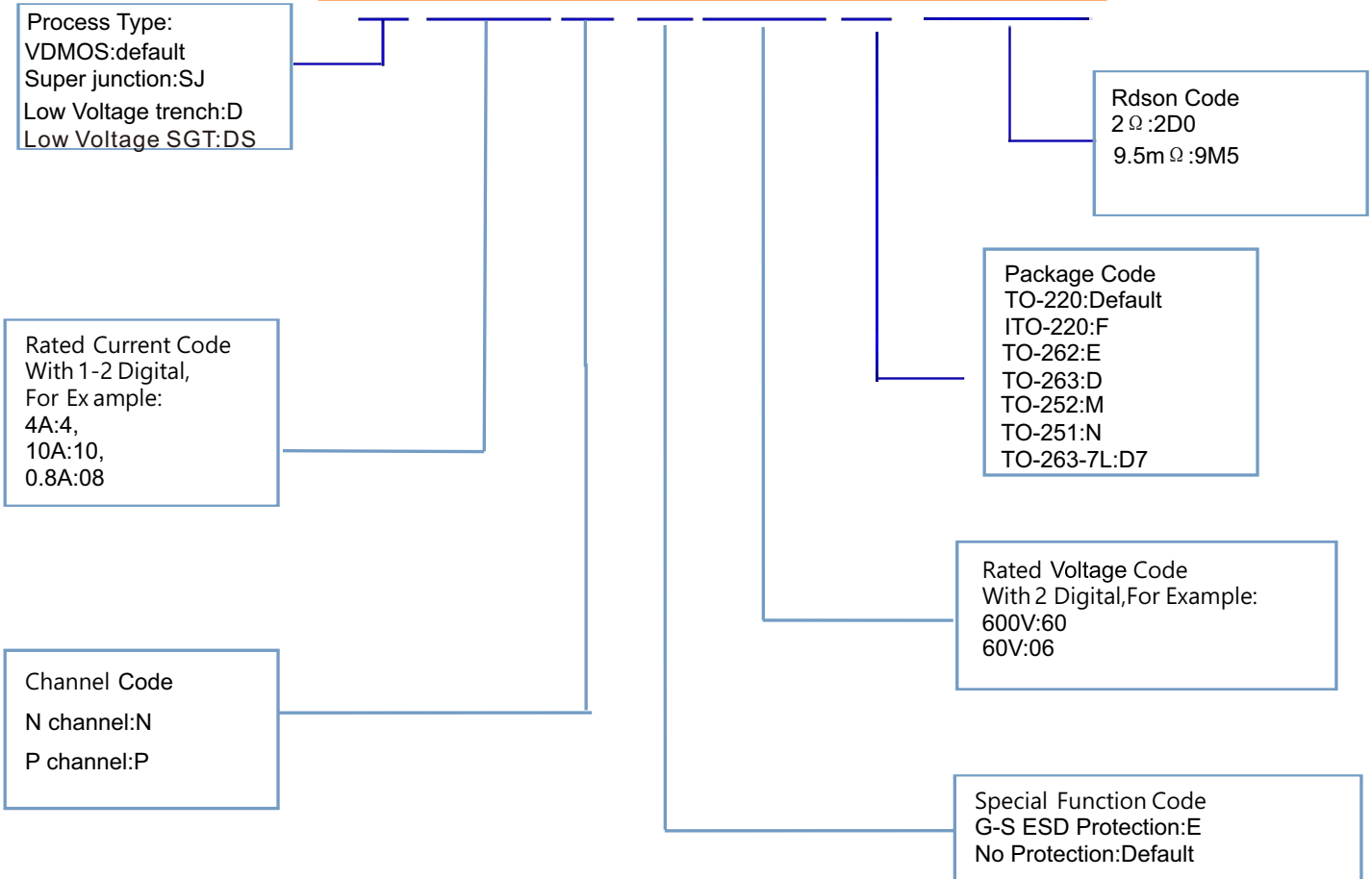
7) . Unclamped Inductive Switching Test Circuit



8) Unclamped Inductive Switching Waveforms

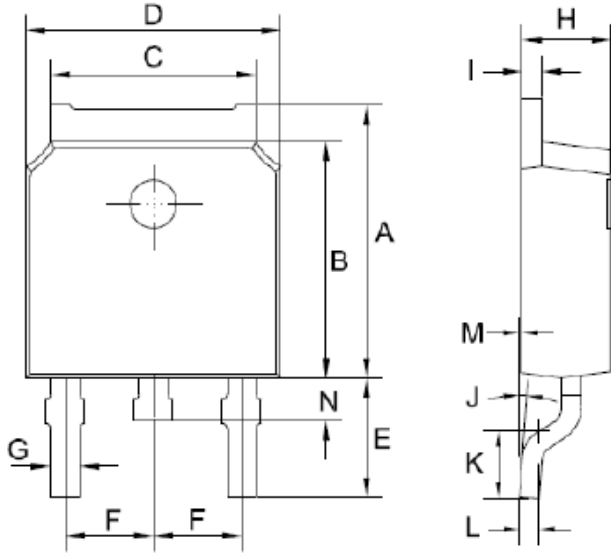
Product Names Rules

X X X N E X X X-X X X



Dimensions

TO-252 PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MIN	MAX	MIN	MAX
A	6.85	7.25	0.270	0.285
B	5.8	6.3	0.228	0.248
C	5	5.53	0.197	0.218
D	6.3	6.8	0.248	0.268
E	2.6	3.3	0.102	0.130
F	2.19	2.39	0.086	0.094
G	0.45	0.85	0.018	0.033
H	2.2	2.4	0.087	0.094
I	0.41	0.61	0.016	0.024
J	0°	8°	0°	8°
K	1.45	1.85	0.057	0.073
L	0.41	0.61	0.016	0.024
M	0	0.12	0.000	0.005
N	0.6	1	0.024	0.039

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